## ◆Section/Keywords List

## NOTICE

Former 3,4,5 categories were merged in to Category 3. Please check the categorty and section again before submission.

Section No. keyword (English) 1.1 Interdisciplinary and General Physics 01101 Interdisciplinary studies 01102 Dynamics 01103 Optics and color 01104 Thermal measurements, analysis, and evaluation 01105 Fluid 01106 Fluid 01107 Static electricity and electromagnetic waves 01108 Tribology 01109 others 01108 Tribology 01109 others 01109 Interdisciplinary studies 011010 Static electricity and electromagnetic waves 01109 Interdisciplinary studies 011010 Fluid 01107 Static electricity and electromagnetic waves 01108 Tribology 01109 others 01109 Interdisciplinary studies 011010 Revelopment of teaching materials, physics experiments 01202 Development of teaching materials, physics experiments 01201 Information education 1.3 Novel Technologies and Frontier Engineering Science 01301 New materials 01302 New materials 01303 Device, process technologies 01304 New mechanisms 01305 Sensor, esning technology, observation method 01306 Characterization technique 01307 Biotechnological applications 01308 Circuit and pipications 01309 Circuit and collision 01310 Ingratis and Collision 01310 Impacts and Collision 01311 Gravity and its application 01312 Others 01312 Others 01312 Others 01312 Others 01313 Others 01313 Others 01314 Sensory conversion 01401 Energy conversion 01401 Energy conversion 01401 Energy conversion 01401 Sensory conservation technology 01409 Nuclear application 01501 Magnetic growners 01501 Resources 01505 Energy 01506 Reuse, reduce, recycle 01501 Magnetic field of fects	Catagory		
Reyword (English)	Category		
1.Applied Physics in General		Language / Facilitak	
1.1 Interdisciplinary and General Physics 0.1102 Dynamics 0.1103 Optics and color 0.1104 Thermal measurements, analysis, and evaluation 0.1105 Pluid 0.1106 Pluid 0.1107 Static electricity and electromagnetic waves 0.1108 Tribology 0.1109 others 1.2 Education 0.1201 System 0.1201 System 0.1201 Information education 1.3 Novel Technologies and Frontier Engineering Science 0.1301 New technologies 0.1302 New materials 0.1303 Device, process technologies 0.1303 Device, process technologies 0.1304 New mechanisms 0.1305 Sensor, sensing technology, observation method 0.1306 Characterization technique 0.1307 Biotechnological applications 0.1308 Occurrent of Characterization technique 0.1309 Chemical applications 0.1309 Chemical applications 0.1310 (Impacts and Collision 0.1311 Gravity and its application 0.1312 Others 1.4 Energy conversion 1.5 Fuel cell 1.6 Fuel cell 1.7 Research 1.7 Resources 1.7 Research 1.7 Research 1.7 Research 1.7 Research 1.7 Research 1.7 Research 1.7 Monitoring, sensing, simulation, LCA, systems 0.1505 Research 1.7 Magnetics and collistion 0.1506 Research 1.7 Monitoring, sensing, simulation, LCA, systems 0.1505 Research 1.7 Magnetics field and its application			
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01C03 Magnetic energy			
01602 Magnetic energy			
01603 Magnetic orientation			
01604 Magneto-science 01605 Instrumentations in magnetic field			
01606 Strong magnetic field			
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Catego	Category		
Section			
No.	keyword (English)		
01701	rumentation and measurement, metrology  Time, frequency, space-time measurement and control		
01701	Dimension, distance, displacement, shape, angle		
01703	Mass, force, torque, gravity, pressure, flow		
01704	Electricity, electromagnetic wave, electromagnetic field		
01705	Optical radiation, optical property		
01706 01707	Temperature, humidity, heat, thermophysical property Nanoscale, particle		
01707	General measurement, limiting measurement, sensing, instrumentation		
01709	Control technology, control theory		
01710	Fundamental physical constant, SI, uncertainty, applied statistics		
01711	Reference material, material database		
01712 01713	Frequency, wavelength, standard time Geometrical quantities, length, angle, surface morphology, critical dimension		
01713	Mechanical quantity, mass, force, pressure, acceleration, acoustics, flow		
	Thermodynamic quantity, temperature, humidity, density, viscosity, thermophysical quantity, PVT		
01716	Electrical quantity, current, voltage, resistance, capacitance, inductance		
	Electromagnetic wave, RF, photometry and radiometry, laser power, ionizing radiation		
1.8 Ultr			
01801 01802	Ultrasonic properties of materials  Measurement techniques		
01803	Phonon physics		
01804	Acousto-optics		
01805	Nondestructive evaluation		
01806 01807	Piezoelectric devices  Nonlinear acoustics		
01807	High power ultrasound		
01809	Sonochemistry		
	Thermo-acoustics		
	Medical ultrasound		
	Underwater sound ng Radiation		
2.1 Ra	diation physics and detectors		
02101	Radiation physics		
02101 02102	Radiation physics Detection principles and fundamentals		
02101 02102 02103	Radiation physics Detection principles and fundamentals Detector materials development		
02101 02102 02103 02104	Radiation physics Detection principles and fundamentals		
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02101 02102 02103 02104 02105 <b>2.2 De</b>	Radiation physics  Detection principles and fundamentals  Detector materials development  Scintillators  Compound semiconductors  tection systems  Detector development		
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02101 02102 02103 02104 02105 <b>2.2 De</b> 02201 02202 02203 02204 <b>2.3 Ap</b> 02301 02302 02303	Radiation physics  Detection principles and fundamentals  Detector materials development  Scintillators  Compound semiconductors  tection systems  Detector development  Signal processing technology  Measurement electronics  Simulation technology  plication of radiation, radiation generators and technologies  Radiation generators  Industrial applications  Medical and biological applications		
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02101 02102 02103 02104 02105 2.2 De 02201 02202 02203 02204 2.3 Ap 02301 02302 02303 02304 02305 02306 02307 02308 02309 02310 02311 3. Optic	Radiation physics  Detection principles and fundamentals  Detector materials development  Scintillators  Compound semiconductors  tection systems  Detector development  Signal processing technology  Measurement electronics  Simulation technology  plication of radiation, radiation generators and technologies  Radiation generators  Industrial applications  Medical and biological applications  Radiation protection and health physics  Cosmic ray  Image processing  Dosimetry  Environmental radioactivity and radiation  Trace element separation and analysis  Radiation standards  Other applications  3,4,5 categories were merged in to Category 3.		
02101 02102 02103 02104 02105 2.2 De 02201 02202 02203 02204 2.3 Ap 02301 02302 02303 02304 02305 02306 02307 02308 02309 02310 02311 3. Optic	Radiation physics  Detection principles and fundamentals  Detector materials development  Scintillators  Compound semiconductors  tection systems  Detector development  Signal processing technology  Measurement electronics  Simulation technology  plication of radiation, radiation generators and technologies  Radiation generators  Industrial applications  Medical and biological applications  Radiation protection and health physics  Cosmic ray  Image processing  Dosimetry  Environmental radioactivity and radiation  Trace element separation and analysis  Radiation standards  Other applications  3,4,5 categories were merged in to Category 3.		
02101 02102 02103 02104 02105 2.2 De 02201 02202 02203 02204 2.3 Ap 02301 02302 02303 02304 02305 02306 02307 02308 02309 02310 02311 3. Optio	Radiation physics  Detection principles and fundamentals  Detector materials development  Scintillators  Compound semiconductors  tection systems  Detector development  Signal processing technology  Measurement electronics  Simulation technology  plication of radiation, radiation generators and technologies  Radiation generators  Industrial applications  Medical and biological applications  Radiation protection and health physics  Cosmic ray  Image processing  Dosimetry  Environmental radioactivity and radiation  Trace element separation and analysis  Radiation standards  Other applications  s and Photonics  3,4,5 categories were merged in to Category 3.  sic optics and frontier of optics  Light scattering, absorption, diffraction, polarization, coherence		
02101 02102 02103 02104 02105 2.2 De 02201 02202 02203 02204 2.3 Ap 02301 02302 02303 02304 02305 02306 02307 02308 02309 02310 02311 3. Option	Radiation physics  Detection principles and fundamentals  Detector materials development  Scintillators  Compound semiconductors  tection systems  Detector development  Signal processing technology  Measurement electronics  Simulation technology  plication of radiation, radiation generators and technologies  Radiation generators  Industrial applications  Medical and biological applications  Radiation protection and health physics  Cosmic ray  Image processing  Dosimetry  Environmental radioactivity and radiation  Trace element separation and analysis  Radiation standards  Other applications  3,4,5 categories were merged in to Category 3.		
02101 02102 02103 02104 02105 2.2 De 02201 02202 02203 02204 2.3 Ap 02301 02302 02303 02304 02305 02306 02307 02308 02309 02311 3. Optic Former 3.1 Bas 03101 03102 03103	Radiation physics  Detection principles and fundamentals  Detector materials development  Scintillators  Compound semiconductors  tection systems  Detector development  Signal processing technology  Measurement electronics  Simulation technology  plication of radiation, radiation generators and technologies  Radiation generators  Industrial applications  Medical and biological applications  Medical and biological applications  Medical in protection and health physics  Cosmic ray  Image processing  Dosimetry  Environmental radioactivity and radiation  Trace element separation and analysis  Radiation standards  Other applications  3,4,5 categories were merged in to Category 3.  sic optics and frontier of optics  Light-matter interaction, electron-photon interaction  Electromagnetic field analysis  Optical vortex, polarized beam		
02101 02102 02103 02104 02105 2.2 De 02201 02202 02203 02204 2.3 Ap 02301 02302 02303 02304 02305 02306 02307 02308 02309 02310 02311 3. Optic Former 3.1 Bas 03101 03102 03103 03104 03105	Radiation physics Detection principles and fundamentals Detector materials development Scintillators Compound semiconductors tection systems Detector development Signal processing technology Measurement electronics Simulation technology plication of radiation, radiation generators and technologies Radiation generators Industrial applications Medical and biological applications Radiation protection and health physics Cosmic ray Image processing Dosimetry Environmental radioactivity and radiation Trace element separation and analysis Radiation standards Other applications Standards Other applications Standards Uther application, decented in the Category 3.		
02101 02102 02103 02104 02105 2.2 De 02201 02202 02203 02204 2.3 Ap 02301 02302 02303 02304 02305 02306 02307 02308 02309 02310 02311 3. Optic Former 3.1 Bas 03101 03102 03103 03104 03105 03106	Radiation physics Detection principles and fundamentals Detector materials development Scintillators Compound semiconductors tection systems Detector development Signal processing technology Measurement electronics Simulation technology pilication of radiation, radiation generators and technologies Radiation generators Industrial applications Medical and biological applications Radiation protection and health physics Cosmic ray Image processing Dosimetry Environmental radioactivity and radiation Trace element separation and analysis Radiation standards Other applications S and Photonics 3,4,5 categories were merged in to Category 3. Sic optics and frontier of optics Light-matter interaction, electron-photon interaction Electromagnetic field analysis Optical vortex, polarized beam Laser trapping, laser manipulation Micro-and nano-optics		
02101 02102 02103 02104 02105 2.2 De 02201 02202 02203 02204 2.3 Ap 02301 02302 02303 02304 02305 02306 02307 02308 02309 02310 02311 3. Optic Former 3.1 Bas 03101 03102 03103 03104 03105 03106 03107	Radiation physics Detection principles and fundamentals Detector materials development Scintillators Compound semiconductors tection systems Detector development Signal processing technology Measurement electronics Simulation technology plication of radiation, radiation generators and technologies Radiation generators Industrial applications Medical and biological applications Radiation protection and health physics Cosmic ray Image processing Dosimetry Environmental radioactivity and radiation Trace element separation and analysis Radiation standards Other applications Standards Other applications Standards Uther application, decented in the Category 3.		

Categor	
Section	
No.	keyword (English)
	terials and equipment optics  Changes in optical characteristics (reflections, refractions, birefringences, structures, absorptions, etc.) and their applications
03201	Optical waveguiding, diffractive optical elements and materials for them
	Nonlinear optical materials, organic optical materials and their elements and applications
03204	Nanomaterials, other materials and their applications
03205	Optical instruments and its designing
03206	Optical fabrication and testing
	Optical memories, related materials, instruments
	Displays, lightings, related materials, instruments
	rmation photonics and image engineering
	Optical & photonic information processing Digital optics
	Computational imaging
	Image processing
	Optical computing
03306	Optical memory system
	Display system, lighting system
	Optical communication system
	medical optics
	Biomedical measurements and analyses
03402 03403	Optical properties of biological tissues Biomedical imaging (OCT, optical topography, etc.)
	Biomedical measurements with ultra-short optical pulses
03404	Fluorescence and Raman microscopy
03406	Photonic therapeutics and diagnostics
03407	Visual information processing, visual function
	Photoacoustic spectroscopy and imaging
	er devices and materials
	DPSS lasers, solid state lasers
03502	Fiber lasers, organic dye lasers
03503	Gas lasers, FEL
03504 03505	Laser materials, nonlinear crystal Pumping technologies, beam control technology, cavity designs, frequency control technologies
	Thermal analysis, thermal compensation technologies
03507	Medium for nonlinear optics, thin film for optics, optical property of materials, periodic-poled medium
03508	The conversion of wavelength, quasi-phase matching, ultraviolet light, tunable laser
03509	Phase conjugate, four-wave mixing, phase conjugate mirror
	Mode-lock laser
	ashort-pulse and high-intensity lasers
	Ultrashort-pulse generation and characterization Ultrashort-pulse laser technology, frequency comb, nonlinear optics
	High-intensity laser systems, parametric amplification
	High-field phenomena, high energy density science
	Ultrafast phenomena
	Short pulse, pulse compression
	er processing
	Fundamentals, monitoring, dynamics
	Thin films, micro- and nanoparticles
	Surface modification
	Micro processing
	High power laser processing Femtosecond process
	Bio and medical applications
	Laser excited phenomena
	ical measurement technology and devices
03801	Interferometric measurement, polarization measurement, spectroscopy and absorption spectra
	Atomic and molecular spectroscopy, high resolution spectroscopy, spectroscopic light source
	Speckle and scattering
03804	Femtosecond measurement
03805	Nanoscale measurement
03806 03807	Measurements of refractive index, film thickness, distance, displacement, velocity and particle diameter
	Optical sensor, optical measurement system Lidar, environmental measurement
	Applied spectroscopy, industrial measurement, microanalysis
	Photoinduced chemistry, biometrics
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	ry
Section	
No.	keyword (English)
	technology
	THz generation and detection, non-linear optics, photoconductive switch, MQW, photo-mixing
	THz optical elements, waveguides, metamaterials, photonic crystals THz system, spectroscopy, imaging, sensing
	THz application, THz probe for carrier dynamics, bio, security, communication
	tical quantum physics and technologies
	Coherent effects
	Quantum correlation, entanglement
031003	Generation and control of quantum states
	Quantum information and computation
	Quantum communication and cryptography
	Atom optics
	Laser cooling
	Laser chaos, chaos synchronization, cipher communication, semiconductor laser with optical feedback otonic structures and phenomena
	Theories of photonic crystals, theories of electro-magnetic field analyses, new photonic structures
	Fabrication processes and materials of multi-dimensional photonic structures
	Photonic crystal lasers, nano lasers, light emitting devices
	Photonic crystal waveguides, photonic nanowires, ultrasmall photonic circuits
031105	Photonic crystal functional devices, nano-size light control devices
	Spontaneous control by photonic nanostructures, control of optical nonlinearities, optical new phenomena
	Metal photonic crystals, metamaterials, plasmons, polaritons
	noscale optical science and near-field optics
	Nanophotonics
	Nano-optoelectronic devices Nanoscale optical fabrication
	Plasmonics and metamaterials
	Raman enhancement
	Electromagnetic-field interaction
	Nonlinear optics
	Scanning probe microscope
031209	Quantum dots
	Atom photonics
	Dressed photon
	miconductor optical devices Semiconductor laser, light emitting diode
	Semiconductor optical amplifier, optical modulators, optical switch, optical functional device, nonlinear device
	Photodiode, photo conductive device, photo-transistor, imaging, sensing
	Optical transmitter, optical receiver, integrated device, module, subsystem, optical communication
021202	Optical transmitter, optical receiver, integrated device, module, subsystem, optical communication  Solar cell
031306 031307	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena
031306 031307 031308	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability
031306 031307 031308 031309	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application
031306 031307 031308 031309 <b>3.14</b> Op	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application tical control devices and optical fiber
031306 031307 031308 031309 <b>3.14 Op</b> 031401	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application  tical control devices and optical fiber Waveguides, passive devices, optical interconnection  Light modulators, entirel switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical
031306 031307 031308 031309 <b>3.14</b> Op	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application tical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical
031306 031307 031308 031309 <b>3.14 Op</b> 031401 031402	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application tical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices
031306 031307 031308 031309 <b>3.14 Op</b> 031401 031402	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application  tical control devices and optical fiber  Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits
031306 031307 031308 031309 <b>3.14 Op</b> 031401 031402 031403	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application tical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices
031306 031307 031308 031309 <b>3.14 Op</b> 031401 031402 031403 031404 031405 031406	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application  tical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors
031306 031307 031308 031309 <b>3.14 Op</b> 031401 031402 031403 031404 031405 031406 <b>3.15 Sili</b>	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application  otical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors icon photonics
031306 031307 031308 031309 <b>3.14 Op</b> 031401 031403 031404 031405 031406 <b>3.15 Sili</b>	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application  tical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors icon photonics Novel materials, process, evaluation
031306 031307 031308 031309 <b>3.14 Op</b> 031401 031403 031404 031405 031406 <b>3.15 Sili</b> 031501	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application  otical control devices and optical fiber  Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors icon photonics Novel materials, process, evaluation Waveguides, passive devices, fiber couplers
031306 031307 031308 031309 <b>3.14 Op</b> 031401 031403 031404 031405 031501 031501 031502	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application  tical control devices and optical fiber  Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors icon photonics Novel materials, process, evaluation Waveguides, passive devices, fiber couplers Optical modulators, optical switches, nonlinear devices
031306 031307 031308 031309 <b>3.14 Op</b> 031401 031403 031404 031405 031501 031501 031502 031503	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application tical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors  con photonics  Novel materials, process, evaluation Waveguides, passive devices, fiber couplers Optical modulators, optical switches, nonlinear devices Light emitters on silicon, group IV light emitting
031306 031307 031308 031309 <b>3.14 Op</b> 031401 031403 031404 031405 031501 031501 031502 031503 031504	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application tical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors  icon photonics Novel materials, process, evaluation Waveguides, passive devices, fiber couplers Optical modulators, optical switches, nonlinear devices Light emitters on silicon, group IV light emitting Photo Detectors
031306 031307 031308 031309 <b>3.14 Op</b> 031401 031403 031404 031405 031501 031501 031502 031503 031504 031505	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application Optical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors icon photonics Novel materials, process, evaluation Waveguides, passive devices, fiber couplers Optical modulators, optical switches, nonlinear devices Light emitters on silicon, group IV light emitting Photo Detectors Optical functional devices, optical integrated circuits, photonics-electronics convergence
031306 031307 031308 031309 <b>3.14 Op</b> 031401 031402 031403 031404 031405 031501 031501 031502 031503 031504 031505 031506 031507	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application tical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors icon photonics Novel materials, process, evaluation Waveguides, passive devices, fiber couplers Optical modulators, optical switches, nonlinear devices Light emitters on silicon, group IV light emitting Photo Detectors Optical functional devices, optical integrated circuits, photonics-electronics convergence Photonic circuits, optical system design
031306 031307 031308 031309 <b>3.14 Op</b> 031401 031402 031403 031404 031405 031501 031501 031502 031503 031504 031505 031506 031507 031508	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application Optical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors icon photonics Novel materials, process, evaluation Waveguides, passive devices, fiber couplers Optical modulators, optical switches, nonlinear devices Light emitters on silicon, group IV light emitting Photo Detectors Optical functional devices, optical integrated circuits, photonics-electronics convergence
031306 031307 031308 031309 <b>3.14 Op</b> 031401 031402 031403 031404 031405 031501 031502 031503 031504 031505 031506 031507 031508 <b>6. Thin</b>	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application tical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors icon photonics Novel materials, process, evaluation Waveguides, passive devices, fiber couplers Optical modulators, optical switches, nonlinear devices Light emitters on silicon, group IV light emitting Photo Detectors Optical functional devices, optical integrated circuits, photonics-electronics convergence Photonic circuits, optical system design Optical signal processing, optical interconnection, optical communication, other applications ilms and Surfaces reelectric thin films
031306 031307 031308 031309 3.14 Op 031401 031402 031403 031404 031501 031502 031503 031504 031505 031506 031507 031508 6. Thin 6.1 Ferr 06101	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application tical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors icon photonics  Novel materials, process, evaluation Waveguides, passive devices, fiber couplers Optical modulators, optical switches, nonlinear devices Light emitters on silicon, group IV light emitting Photo Detectors Optical functional devices, optical integrated circuits, photonics-electronics convergence Photonic circuits, optical system design Optical signal processing, optical interconnection, optical communication, other applications Ferroelectric, dielectric thin films Ferroelectric, dielectric thin films
031306 031307 031308 031309 3.14 Op 031401 031402 031403 031404 031405 031501 031502 031503 031504 031505 031506 031507 031508 6. Thin 6.1 Ferr 06101 06102	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application tical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors icon photonics Novel materials, process, evaluation Waveguides, passive devices, fiber couplers Optical modulators, optical switches, nonlinear devices Light emitters on silicon, group IV light emitting Photo Detectors Optical functional devices, optical integrated circuits, photonics-electronics convergence Photonic circuits, optical system design Optical signal processing, optical interconnection, optical communication, other applications Ferroelectric, dielectric thin films Ferroelectric, dielectric thin films Multiferroic thin films
031306 031307 031308 031309 3.14 Op 031401 031402 031403 031404 031405 031501 031502 031503 031504 031505 031506 031507 031508 6. Thin 6.1 Ferr 06101 06102 06103	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application tical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors icon photonics Novel materials, process, evaluation Waveguides, passive devices, fiber couplers Optical modulators, optical switches, nonlinear devices Light emitters on silicon, group IV light emitting Photo Detectors Optical functional devices, optical integrated circuits, photonics-electronics convergence Photonic circuits, optical system design Optical signal processing, optical interconnection, optical communication, other applications Films and Surfaces roelectric thin films Ferroelectric, dielectric thin films Electrode materials
031306 031307 031308 031309 3.14 Op 031401 031402 031403 031404 031405 031501 031502 031503 031504 031505 031506 031507 031508 6. Thin 6.1 Ferr 06101 06102 06103 06104	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application tical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors  con photonics Novel materials, process, evaluation Waveguides, passive devices, fiber couplers Optical modulators, optical switches, nonlinear devices Light emitters on silicon, group IV light emitting Photo Detectors Optical functional devices, optical integrated circuits, photonics-electronics convergence Photonic circuits, optical system design Optical signal processing, optical interconnection, optical communication, other applications Films and Surfaces  roelectric, dielectric thin films Ferroelectric, dielectric thin films Ferroelectric, piezoelectric devices Ferroelectric, piezoelectric devices
031306 031307 031308 031309 3.14 Op 031401 031402 031403 031404 031405 031501 031502 031503 031504 031505 031506 031507 031508 6. Thin 6.1 Ferr 06101 06102 06103	Solar cell High sensitivity optical sensing, noise characteristics Optical property of semiconductors, phenomena Designing, evaluation, materials, processing, reliability Novel material, devices, application tical control devices and optical fiber Waveguides, passive devices, optical interconnection Light modulators, optical switch, wavelength conversion device, quasi phase matching, quasi velocity matching, periodical poling, other devices Integrated device, optical integrated circuits module, subsystem, system, optical communication Optical fiber (structures, characteristics, materials, process, evaluation) Optical fiber devices, sensors icon photonics Novel materials, process, evaluation Waveguides, passive devices, fiber couplers Optical modulators, optical switches, nonlinear devices Light emitters on silicon, group IV light emitting Photo Detectors Optical functional devices, optical integrated circuits, photonics-electronics convergence Photonic circuits, optical system design Optical signal processing, optical interconnection, optical communication, other applications Films and Surfaces roelectric thin films Ferroelectric, dielectric thin films Electrode materials

Section  6.2 Carbon-based thin films  6.2 Carbon-based thin films  6.2010 Diamond thin films  6.2023 Amorphous carbon thin films  6.2023 Amorphous carbon thin films  6.2034 Amorphous carbon thin films  6.2034 Amorphous carbon thin films  6.2036 Amorphous carbon thin films  6.2037 Amorphous carbon thin films  6.2038 Amorphous carbon thin films  6.2030 Amorphous carbon thin films  6.2030 Amorphous carbon thin films  6.2031 Amorphous carbon c	Category		
62.21 Dismonth thin films 62.22 Microcrystalline diamond 62.23 Amorphous carbon thin films 62.23 Amorphous carbon thin films 62.24 B. C-N thin films 62.25 Oxides for electronic functionalities 62.26 Oxides functionalities 62.27 Oxides functionalities 62.	Section		
Jözzot Minory Statistics Statisti			
Microcrystalline diamond			
Marchael			
36.204   Service   Servi			
\$3.0 Dide based electronics   \$3.01 Dides for electronic functionalities   \$3.01 Dides for electronic functionalities   \$3.03 ReaAM			
Doubles for electronic functionalities			
Jistongly correlated electron system  Jistongly correlated electron sy			
0.6303 MeRAM 0.6304 Wide gap semiconductors and transparent materials 0.6305 Mere cells and photocatalysts 0.6306 Inolic transport and rechargeable battery 0.64 New thin-film materials "english session is scheduled 0.6401 Dielectric thin films 0.6402 Semiconductive and conductive thin films 0.6403 Metal thin films 0.6403 Metal thin films 0.6404 New materials and technologies 0.6504 Surface physics and vacuum 0.6504 Israfe physics and vacuum 0.6505 Israfe physics and vacuum 0.6505 Israfe physics and vacuum 0.6504 Surface ananostructures 0.6505 Mesurement methods and theories 0.6505 Mesurement methods and theories 0.6506 Mesurement methods and theories 0.6506 Mesurement methods and theories 0.6506 Probe microscopy 0.6601 Sanning probe microscopy 0.6601 Sanning probe microscopy 0.6602 Nanoscience 0.6603 Nanotechnology 0.6604 Nanoprobes 0.6606 Abanoprobes 0.6606 Abanoprobes 0.6606 Abanoprobes 0.6606 Abanoprobes 0.6606 Abanoprobes 0.6606 Abanoprobes 0.78 Beat technologies 0.7101 X-ray sources 0.7102 X-ray devices 0.7103 X-ray optics 0.7103 X-ray optics 0.7104 X-ray temporoscopy 0.7105 X-ray applications 0.7106 Abanoproscopy 0.7106 Abanoproscopy 0.7107 X-ray mesurement 0.7108 Invariance and mere and mere analysis 0.7109 Mere and mere analysis 0.7109 Mere analysis 0.7109 Mere analysis 0.7109 Mere analysis 0.7101 Mere			
Mide gap semiconductors and transparent materials			
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7.7 Vacuum nanoelectronics and electron sources	
07701 Emission properties of electron sources	
07702 Fabrication of electron sources	
07703 Characterization of electron sources	
07704 Materials for electron sources 07705 Applications of vacuum nanoelectronics and electron sources	
07705 Applications of vacuum nanoelectronics and electron sources 07706 Emission fundamental and modeling	
07707 Novel technologies for electron emission and vacuum tunneling	
7.8 New beam-application technologies	
07801 New application technologies and instruments of atomic and molecular beams	
07802 New application technologies and instruments of electron beams	
07803 New application technologies and instruments of ion beams	
07804 New application technologies and instruments of laser beams	
07805 New application technologies and instruments of synchrotron radiation	
07806 New application technologies and instruments of optical lithography and its related techniques	
8. Plasma Electronics English session is scheduled in 8. If you choose "English" as the presentation language, your presentation will be preferentially pro	ananana ad in
8.1 Plasma production and control	grammed in
08101 Production and control of microwave plasmas	
08102 Production and control of RF plasmas	
08103 Production and control of atmospheric non-thermal plasmas	
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08105 Production and control of plasmas in or on liquid 08106 Production and control of reactive plasmas 08107 Simulations of plasma production and control 08108 Production and control of other plasmas  8.2 Plasma measurements and diagnostics 08201 Optical measurements and diagnostics 08202 Particle measurements and diagnostics 08203 Solid and liquid surface condition measurements 08204 Plasma/surface reactions and diagnostics 08205 Process monitoring techniques 08206 Other techniques 8.3 Plasma deposition of thin film and surface treatment 08301 CVD, PVD and sputtering 08302 Surface treatment, modification, and functionalization 08303 Organic processing 08304 Equipment and control technique 08305 Process cleaning 08306 Particle growth	
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08105 Production and control of plasmas in or on liquid 08106 Production and control of reactive plasmas 08107 Simulations of plasma production and control 08108 Production and control of other plasmas  8.2 Plasma measurements and diagnostics 08201 Optical measurements and diagnostics 08202 Particle measurements and diagnostics 08203 Solid and liquid surface condition measurements 08204 Plasma/surface reactions and diagnostics 08205 Process monitoring techniques 08206 Other techniques 8.3 Plasma deposition of thin film and surface treatment 08301 CVD, PVD and sputtering 08302 Surface treatment, modification, and functionalization 08303 Organic processing 08304 Equipment and control technique 08305 Process cleaning 08306 Particle growth 08307 Arc and plasma jets	
08105       Production and control of plasmas in or on liquid         08106       Production and control of reactive plasmas         08107       Simulations of plasma production and control         08108       Production and control of other plasmas         8.2 Plasma measurements and diagnostics         08201       Optical measurements and diagnostics         08202       Particle measurements and diagnostics         08203       Solid and liquid surface condition measurements         08204       Plasma/surface reactions and diagnostics         08205       Process monitoring techniques         08206       Other techniques         8.3 Plasma deposition of thin film and surface treatment         08301       CVD, PVD and sputtering         08302       Surface treatment, modification, and functionalization         08303       Organic processing         08304       Equipment and control technique         08305       Process cleaning         08306       Particle growth         08307       Arc and plasma jets         8.4 Plasma etching         08401       Etching technology for Si and conductive materials	
08105     Production and control of plasmas in or on liquid       08106     Production and control of reactive plasmas       08107     Simulations of plasma production and control       08108     Production and control of other plasmas       8.2 Plasma measurements and diagnostics     08201       08201     Optical measurements and diagnostics       08202     Particle measurements and diagnostics       08203     Solid and liquid surface condition measurements       08204     Plasma/surface reactions and diagnostics       08205     Process monitoring techniques       08206     Other techniques       8.3 Plasma deposition of thin film and surface treatment       08301     CVD, PVD and sputtering       08302     Surface treatment, modification, and functionalization       08303     Organic processing       08304     Equipment and control technique       08305     Process cleaning       08306     Particle growth       08307     Arc and plasma jets       8.4 Plasma etching       08401     Etching technology for dielectric materials       08402     Etching technology for new materials and new structures	
08105       Production and control of plasmas in or on liquid         08106       Production and control of reactive plasmas         08107       Simulations of plasma production and control         08108       Production and control of other plasmas         8.2 Plasma measurements and diagnostics         08201       Optical measurements and diagnostics         08202       Particle measurements and diagnostics         08203       Solid and liquid surface condition measurements         08204       Plasma/surface reactions and diagnostics         08205       Process monitoring techniques         08206       Other techniques         8.3 Plasma deposition of thin film and surface treatment         08301       CVD, PVD and sputtering         08302       Surface treatment, modification, and functionalization         08303       Organic processing         08304       Equipment and control technique         08305       Process cleaning         08306       Particle growth         08307       Arc and plasma jets         8.4 Plasma etching         08402       Etching technology for dielectric materials         08403       Plasma induced damage and process integration	

	ategory		
Section	h 1/= 0.13		
	keyword (English) sma nanotechnology		
	Nanotubes, nanowalls, nanohorns and graphene		
	Fullerenes and nano particles		
	Plasma nanoprocessing		
	Self-organized and self-assembled films		
	Structure control and new structure		
00000	Synthesis of nanostructured materials Properties and functions enhanced by nanostructure		
	Nanodevices		
	eral plasma phenomena, emerging area of plasmas and their new applications		
08601	Fundamental processes in atomic, molecular and gas discharges		
08602	Light sources and displays		
	Laser plasmas		
	Plasma photonics Plasma biological applications		
08606	Environmental and energy applications		
08607	Liquid and in-liquid plasma applications		
	Plasma medical applications		
	Plasma agricultural applications		
	Novel plasma applications		
	ed Materials Science ectrics, ferroelectrics		
	Dielectric, ferroelectric, and piezoelectric materials		
	Dielectric and piezoelectric properties		
09103	Domains		
	Layered compounds		
	Ceramics and single crystals		
	Characterization and measurement techniques owires, nanoparticles		
	nanowires		
	nanoparticles		
	powder/fine particles: electric charge, discharge, and ions		
09204	hybrids between nanowires and nanoparticles, between inorganic and organic materials		
	formation mechanisms		
	characterization of nano-material properties characterization methods		
	applications to nanobiotechnologies, energy harvesting technologies, novel/multi-functional devices		
	safety evaluations		
	oelectronics		
	Quantum and nanoscale devices		
	Nanoscale materials and structures: fabrication and characterization		
	Physical properties of nanoscale materials and structures  Nanoscale devices: new concepts and architectures		
	Quantum information		
	rmoelectric conversion		
	Oxide materials		
	Compound semiconductors		
	Systems and modules  Measurements		
	Others		
	v functional materials and new physical properties		
	Novel functional materials, novel physical properties		
09502	Characterization methods for novel functional materials, novel physical properties		
09503	Luminescent materials, memory materials, and magnetostriction materials and sensor applications		
09504	Environmentally friendly semiconductors, energy storage materials, thermal conductive materials, heat radiation materials, nano materials		
10. Spin	tronics and Magnetics		
	presentations are welcomed in this category. Outstanding presentations by student speakers will be awarded by Professional Group of		
10.1 Cre	eation of new materials		
	Spin-functional oxides and their heterostructures		
	Heusler alloys and their heterostructures		
	Novel magnetic materials and their heterostructures  Nanostructured magnetic materials (including nanoparticles) and their fabrication processes and simulations		
	in torque, spin current, circuits, and measurement technologies		
	MRAM (including circuit and device designs)		
	Spin-dependent transport phenomena and devices (including circuit and device designs)		
10203	Magnetic imaging, measurements and instrumentation		
	Fabrication processes for magnetic devices		
10205	Novel spin transport phenomena		

Categor	Category		
Section			
No.	keyword (English)		
10.3 Gia	ant magnetoresistance (GMR), tunnel magnetoresistance (TMR) and magnetic recording technologies		
	Materials and fabrication technologies for TMR and GMR devices		
10302	Magnetic recording technologies (HDD, etc.)		
10303	Magnetic sensors		
10304	High frequency devices		
10305	Other spin and magnetic devices (including device and circuit designs)		
10.4 Sei	miconductors, organic, optical, and quantum spintronics		
10401	III-V magnetic semiconductors and their heterostructures		
10402	IV magnetic semiconductors and their heterostructures		
10403	II-VI magnetic semiconductors and their heterostructures		
10404	Spin-functional organic materials and their heterostructures		
	Spin-dependent optical devices and phenomena (including device and circuit designs)		
	Detection and manipulation of nuclear spin		
	Spin-based quantum communication and computer		
	Other novel spin related phenomena		
	erconductivity		
	ndamental properties		
	Novel phenomena, physics and chemistry, theory		
11102	Crystal growth, substitution effect, intercalation  Josephson effect, intrinsic Josephson junctions		
11103			
11104	Vortex properties, high-frequency response		
	Novel superconducting materials, new evaluation technology Bismuth and thallium systems		
11106 11107	123 cuprate superconductors		
	214 superconductors, other oxide superconductors		
	Metallic superconductors, organic superconductors, Non-copper oxide superconductors		
	in films, thick films, coated conductors and thin film crystal growth		
	YBCO and REBCO thin films		
11202	Bi-, Tl- and Hg-oxide thin films		
11203	Coated conductor process		
11204	Large-area thin films		
11205	Low-Tc thin films		
11206	Thin film crystal growth		
11207	Others		
	tical current, superconducting power applications		
11301	Critical current, pinning, E-J characteristics		
	Electromagnetic phenomenon		
	Evaluation of characteristics of thin films		
11304	Evaluation of characteristics of wires		
11305	Evaluation of characteristics of bulks		
	Superconducting power applications		
	Methods for evaluations		
11308	Others alog application and its related technologies		
11.4 AII 11401	SQUID and its applications (device structures, properties of devices, amplifiers, etc. )		
11401	Microwave devices and applications (microwave passive devices, filters, antennas, tunable filters, active devices, etc.)		
11403	Mixers, transmitters, and receivers (heterodyne receivers, transmitters, bolometers, STJ detectors, transition edge sensors )		
11404	Other analog devices		
11405	Advanced measurement application and its related technologies (SQUID measurements, voltage standards, cryogenic		
	systems, magnetic shielding technologies, etc. )		
	nction, circuit fabrication process and digital applications		
11501	Josephson junction fabrication process (LTS, HTS, NbN, MgB2, etc.)		
11502	Circuit fabrication process (LTS, HTS, NbN, MgB2 etc.)		
11503 11504	Circuit design (circuit simulation, optimized design, circuit design tool) Small/middle scale circuit application (AD converter, etc.)		
11504	Large scale application (server, router, etc.)		
11505	Other applications		
11300	ение арричения		

Catego	ry
Section	
No.	keyword (English)
	anic Molecules and Bioelectronics
	brications and Structure Controls
12101	Dry processes (vacuum evaporation, chemical vapor deposition)
12102	Wet processes (spin coating, dip coating, spray deposition, inkjet printing, Langmuir-Blodgett technique, self-organization,
12102	self-assembled monolayer)
12103	Epitaxy, epitaxial growth Electrochemical crystal growth
12104 12105	Control of molecular alignment, orientation
12106	Liquid crystals (phase transition, structure and ordering, polymer network)
12107	Liquid crystal alignment (surface alignment, photoalignment, anchoring)
12108	Micro and nanoparticles
12109	Organic-inorganic hybrids
12110	Organic nanocrystals, nanoarchitecture
12111	Nanopores, nanosheets
12112	Other fabrication techniques
	aracterization and Materials Physics
	Scanning probe microscopy (STM, AFM, KPFM, SNOM, etc.)
12202	Spectroscopic analyses (photoelectron, laser, vibrational, ESR, EELS, thermally stimulated current, etc.)
	Structural analyses (X-ray diffraction, electron beam diffraction, etc.)
12204	Surface plasmmon resonance and spectroscopy
12205	Carrier transport phenomena, thermal transport phenomena  Molecular-scale electronics and photonics
12206 12207	Theoretical study and simulation
	Other analyses and characterization techniques
	nctional materials and novel devices
	Electro- and optical-functional materials (molecular design, synthesis, characterization)
	Liquid crystals
12303	Organic semiconductors Control of the Control of th
12304	Conductive polymers
12305	Self assembled materials
12306	Soft materials (polymer, gel, colloid)
12307	Optical functional materials (nonlinear optics, photoinduced structural change and photoisomerization, luminescence, lasing)
12308	Exciton and plasmon engineering
12309	Electronic devices (photoelectron conversion, thermoelectric conversion, sensor, memory, etc.)
12310	Optical functional devices (luminescence device, optical waveguide, microcavity, etc.)
12311	Liquid crystal devices (display, photonics, biological applications, etc.)
12312	Polymer functional devices
	Polymer electronics
12.4 Or	ganic light-emitting devices and organic transistors
12401	Fundamental properties of organic devices (device physics, carrier transport, carrier injection, interfaces, surfaces, molecular ordering)
12402	Degradation mechanism
12403	Highly efficient OLEDs and materials
12404	Small-molecule OLEDs and materials
12405	Polymer OLEDs and materials
12406	OLED fabrication technology
12407	Light extraction
12408	Application of OLEDs (display, lighting, etc.)
	Transistor materials (synthesis, evaluation, properties)
	Transistor fabrication technology (electrode, gate dielectric, surface treatment)
12411	Application of transistors (display, sensor, memory, integration circuit)
12412	Novel devices (light-emitting transistors, organic semiconductor lasers, etc.)  ganic solar cells
12.5 Or	Organic photovoltaic cells
12501	Dye-sensitized solar cells
12503	Organic–inorganic hybrid solar cells, nanostructured solar cells, advanced solar cells
12504	Photovoltaic science (photophysics, device physics, charge transport, optical and electronic properties, etc.)
12505	New organic semiconductor materials (polymers, small molecules, dyes, etc.), interfacial materials, barrier materials
12506	Photovoltaic systems, reliability and testing techniques, field testing techniques
12507	Photovoltaic modules, large-area manufacturing techniques, roll-to-roll fabrication techniques
12508	Photovoltaic batteries, other combined techniques

Catego Section	
No.	keyword (English)
	anobiotechnology
	Nanomaterials and nanostructures for biosensor and biochip
12601	(DNA chip, protein chip, cell chip)
	Measurement and manipulation of single molecule and single cell (including mechanics and optics)/ high-sensitivi
12602	detection, spectroscopic or imaging method for biology
12603	Nanobio-process, self-assembly and self-organization of biomolecules/ bio-inspired materials
	Bio-interface and related techniques (surface treatment, modification, patterning and microfabrication)
	Nanobioelectronics, nanobiophotonics, nanobio-green technology
	Other nano&bio interdisciplinary fields
	edical Engineering and Biochips
	Cell function, biological function, biological property, biophysics, regenerative medicine (tissue engineering)
	Medical engineering, medical robotics, biophotonic devices, biosensors, chemical sensors
	Genetic engineering, protein engineering, supramolecular engineering
	Smartbiochips, bioelectronics
	Bio-MEMS, μ-TAS
	Biomaterial, biomass, biomimetics
12707	Bioimaging
	niconductors A (Silicon)
	sic Properties, Surface and Interface Phenomena, and Simulation
13101	Material properties
	Novel functions
13103	Novel characterization
13104	Nano structures
13105	Interface
13106	Thin films
13107	Theory
13108	Surface preparation
13109	Reaction, nucleation, and initial film growth
13110	Contamination detection and removal
13111	Adsorption and desorption
13112	Fine structure
13113	Aqueous etching
	Process simulation
	Device simulation
	Circuit simulation
	Thermal transport simulation
	Others
	sulator technology
	Gate insulator
13202	Silicon oxide/silicon oxynitride/silicon nitride
	high-k film
	Ge/SiGe/Strained-channel
	III/V group semiconductor
	Film formation method/evaluation method
13207	Electrical property/reliability
	Model/simulation
	Passivation film
13210	Insulative film for Memory devices(Floating gate, Charge trapping, ReRAM)  Gate stack for TFT
13211	

	Category		
Section			
	keyword (English)		
	Process Interconnect MEMS Integration		
	SOI		
	TFT		
13303	Epitaxy/CVD/sputter		
13304	Impurity doping/shallow junction/transient enhanced diffusion		
13305	Low- and high-temperature poly-Si and related materials  Gate materials		
13306 13307	Process-induced defect		
	Nanoscale process		
	Metal-semiconductor interface/Contact		
	Silicide		
	Interconnnect/Process/Materials/Barrer metal		
13312	Interlayer dielectrics/Low-k material/Barrier dielectric		
	Planarization/Lamination/bonding		
	3D stacking/TSV/Redistribution Layer		
	MEMS/NEMS/Sensor		
13316	Biodevice		
13317	Reliability		
	Packaging		
	Multi-pyhsics simulation		
	Others		
	vices/Integration Technologies		
	New device structures (Nanowire, FinFET, etc.)		
	New material devices (Si, Ge, III-V, oxide channel, etc.)		
13403	Quantum effect devices (SET, QD, Tunnel, Spin, etc.)		
13404	Non-volatile memories (Flash, ReRAM, MRAM, FeRAM, etc.)		
	Integration technologies (New process, etching, junction, etc.)  Device operating principles and various phenomena		
	Reliability and measurement techniques		
	Circuit design		
	others		
	English Session *All-English session		
	Presentation in English		
14. Sem	iconductors B (Exploratory Materials, Physical Properties, Devices)		
	ysical properties of exploratory materials		
	Semiconducting silicides		
	Properties of new materials, material design		
	Impurity, defect, deep level		
	Carrier transport		
	Evaluation technique, new principle		
	crathin films and quantum nanostructures  Quantum dots		
	Quantum wires		
14202 14203	Quantum wires  Quantum wells		
1.200	Optical properties in low-dimensional materials		
	Electronic properties in low-dimensional materials		
	Tunneling effects		
	Nanostructure fabrication		
	Nanodevices		
	ctron devices and Process technology		
14301	Nitride semiconductor electron devices and circuits		
14302	III-V channel electron devices and circuits		
	Functional devices with new materials and/or new concepts		
	Process technology and characterization of nitride devices		
	Process technology and characterization of III-V devices		
	tical properties and light-emitting devices		
	Si-based materials		
	Rare-earth doped materials		
	EL (Phosphor, Inorganic EL) Others		
	mpound solar cells		
	III-V solar cells		
	Quantum structured solar cells		
	Nitride/oxide solar cells		
14504	Chalcogenide solar cells		
	Novel solar cells and related materials		
_ ,505			

Seyword English	Categor	
15.1 But crystal growth		
15101   Use of properties and function		
15103   Discostion		
15104   Melt growth		
15.1016   Topstal growth		
15.2 ILV-group crystals and multicomponent crystals		
15202   Electrical properties     15203   Electrical properties     15204   Nano-structure     15205   New materia, multi-element oxide     15206   Nano-structure     15207   Nano-structure     15208   Nano-structure     15208   Nano-structure     15209   Nano-s	10100	
Blectrical properties		
15205. New materia, multi-element oxide 15206. Nano-structure 15206. Nano-structure 15206. Nano-structure 15206. Nano-structure 15301. Diluted nitrides 15302. Sho-containing alloys 15302. Sho-containing alloys 15303. Memory patival increases 15304. MSE 15305. MCVO/MOMSE 15401. Spanner structures 15401. Policia properties and characterization 15402. Electronic properties and characterization 15402. Electronic properties and characterization 15403. Electronic properties and characterization 15404. Electronic properties and characterization 15405. Elike crystals and freestanding crystals 15406. Elike crystals and freestanding crystals 15407. Electronic properties and characterization 15407. Electronic properties and characterization 15409. Elike crystals and IV-IV-group mixed crystals 15501. SiGe (See) virtual substrate 15502. SiGe (See) virtual substrate 15503. Quantum dot, nano structure 15504. Poly SyGe 15503. Guantum dot, nano structure 15504. Poly SyGe 15506. Crystal syrowth 15507. Elike control, defect 15508. Processing 15601. Crystal growth 15602. Elitaxial growth 15603. Contact 15604. Didde and other clienterics 15605. Processing 15607. Elitaxial growth 15607. Elitaxial growth 15607. Elitaxial growth 15608. Electronic structures 158. Crystal evaluation, impurities and crystal defects 158. Crystal evaluation, impurities and crystal defects 158. Fortal evaluation, impurities and crysta		
13,3111-Y-group epitaxial crystals		·
15.3 III - V-group epitaxial crystals		
Jaion   Diluted intrides		
15303   Male	15301	Diluted nitrides
15305 MOCVO/MOMBE 15.4 III-V-group nitride crystals 15.4011 Optical properties and characterization 15401 Epitaxial growth (MOVPE, MBE) 15402 Electronic properties and characterization 15403 Epitaxial growth (MOVPE, MBE) 15404 Cubic GaN 15405 Bulk crystals and freestanding crystals 15406 Discoation 15407 Devices (LD, LED and photo detectors) and their process 15408 InN 15409 AIN 15409 AIN 15501 Side (Ge) virtual substrate 15502 Sidesin, Sidec 15503 Quantum dot, nano structure 15503 Usin Modern (Company) (Compan		• ,
15305   MOCVO/MOMBE 154 III-V-group nitride crystals 15401   Optical properties and characterization 15402   Electronic properties and characterization 15403   Electronic properties and characterization 15404   Cubic GaN		·
15401 Optical properties and characterization 15402 Eletromic properties and characterization 15403 Epitaxial growth (MOVPE, MBE) 15404 Cubic GaN 15405 Bulk crystals and freestanding crystals 15406 Dislocation 15407 Devices (LD, LED and photo detectors) and their process 15408 InN 15507 Devices (LD, LED and photo detectors) and their process 15408 InN 15508 InN 15501 SiGe(Ge) virtual substrate 15502 SiGesh, SiGeC 15503 Quantum dot, nano structure 15504 Poly Si/Ge 15505 Sol), GOI 15506 Strained Si, Ge 15507 Optical device 15508 Crystal growth 15509 Poly Side growth 15500 Optical device 15501 Crystal growth 15601 Crystal growth 15602 Devices 15605 Poly Crystal growth 15600 Poly Crystal g	15305	MOCVD/MOMBE
Electronic properties and characterization		
Epitaxial growth (MOVPE, MBE)		
15406 Dislocation 15407 Devices (LD, LED and photo detectors) and their process 15408 InN 1551947 Devices (LD, LED and photo detectors) and their process 15409 InN 1551949 AIN 1551949 AIN 155194506 Devices (LD, LED and photo detectors) and their process 15501 SiGeGel virtual substrate 15502 SiGeSn, SiGeC 15503 Quantum dot, nano structure 15504 Poly Si/Ge 15505 Poly Si/Ge 15505 Sol, GOI 15506 Strained Si, Ge 15507 Dislocation, defect 15508 Crystal growth 15509 Optical device 15509 Optical device 15501 SiGeSn growth 15601 Crystal growth 15601 Crystal growth 15602 Contact 15604 Oxide and other delectrics 15605 Processing 15606 Devices 15607 Characterization 1577 Fundamentals of epitaxy 15701 Theory 15702 Growth mechanism 15703 Surface structures 15804 Polyta extructures 15806 Impurity effect 15807 Impurity effect 15808 Impurity effect 15806 Impurity effect 15807 Inferogenation 15808 Impurity effect 15809 Impurity effect 15800 Impurity effect 15800 Impurity effect 15800 Impurity effect 15801 Impurity effect 15802 Impurity effect 15803 Impurity effect 15803 Impurity effect 15804 Oxide materials 15806 Impurity effect 15807 Impurity effect 15808 Impurity effect 15808 Impurity effect 15809 Impurity effect 15800 Impurity effect 15800 Impurity effect 15800 Impurity effect 15800 Impurity effect 15801 Impurity effect 15802 Impurity effect 15803 Impurity effect 15804 Oxide effect 15803 Impurity effect 15804 Oxide effect	15403	Epitaxial growth (MOVPE, MBE)
Dislocation	-	
15407   Devices (LD, LED and photo detectors) and their process		
15.51 V-group crystals and IV-IV-group mixed crystals	15407	
15.51   SiGe(Ge) virtual substrate		
15501 SiGe(Ge) virtual substrate 15502 SiGeSn, SiGeC 15503 Quantum dot, nano structure 15504 Poly Si/Ge 15505 SGOI, GOI 15506 Strained Si, Ge 15507 Dislocation, defect 15508 Crystal growth 15509 Optical device 15500 Very group-based compounds 15601 Crystal growth 15602 Epitaxial growth 15603 Contact 15604 Oxide and other dielectrics 15605 Processing 15600 Devices 15607 Characterization 15.7 Fundamentals of epitaxy 15701 Theory 15702 Surface structures 15.8 Crystal evaluation, impurities and crystal defects 15801 Point defect 15802 Impurity effect 15803 Hydrogenation 15804 Impurity effect 15805 Electrical characterization 15806 Devices 15807 Impurity effect 15808 Point defect 15809 From the defect 15800 From the defect 15800 From the defect 15801 From the defect 15801 From the defect 15802 Impurity effect 15803 Hydrogenation 15805 Electrical characterization 15806 From the defect 15807 From the defect 15807 From the defect 15808 From the defect 15809 From the defect 15800 From the defect 15800 From the defect 15800 From the defect 15801 From the defect 15801 From the defect 15802 Impurity effect 15803 From the defect 15803 From the defect 15804 From the defect 15805 From the defect 15806 From the defect 15807 From the defect 15808 From the defect 15809 From the defect 15800 From		
15504 Poly Si/Ge 15505 ScO, GOI 15506 Strained Si, Ge 15507 Dislocation, defect 15508 Crystal growth 15509 Optical device 15508 Crystal growth 15509 Optical device 15.6 IV-group-based compounds 15601 Crystal growth 15602 Epitaxial growth 15603 Contact 15604 Oxide and other dielectrics 15605 Processing 15606 Devices 15607 Characterization 15.7 Fundamentals of epitaxy 15701 Theory 15701 Theory 15702 Growth mechanism 15703 Surface structures 15808 I Point defect 15809 I Point defect 15809 I Point defect 15809 I Point defect 15800 Impurity effect 15800 Impurity effect 15800 Electrical characterization 15.8 Crystal evaluation impurities and crystal defects 15801 Electrical characterization 15.8 Crystal evaluation impurities and crystal defects 15801 Electrical characterization 15804 Optical characterization 15805 X-ray characterization 15.8 Crystal evaluation impurities and crystal defects 15801 Electrical characterization 15806 Electrical characterization 15807 Condition of the defect	15501	SiGe(Ge) virtual substrate
15505   Poly Si/Ge		
15506 Strained Si, Ge 15507 Dislocation, defect 15508 Crystal growth 15509 Optical device 15.6 Negroup-based compounds 15601 Crystal growth 15602 Epitaxial growth 15603 Contact 15604 Oxide and other dielectrics 15605 Processing 15606 Devices 15607 Characterization 15.7 Fundamentals of epitaxy 15701 Theory 15701 Theory 15702 Growth mechanism 15703 Surface structures 15.8 Crystal evaluation, impurities and crystal defects 15801 Point defect 15802 Impurity effect 15803 Hydrogenation 15804 Optical characterization 15805 X-ray characterization 15806 Electrical characterization 15807 Surface structures 15801 Point defect 15802 Impurity effect 15803 Hydrogenation 15805 K-ray characterization 15806 Electrical characterization 15806 Information of the control of the con		
15507 Dislocation, defect 15508 Crystal growth 15509 Optical device 15.6 IV-group-based compounds 15601 Crystal growth 15602 Epitaxial growth 15603 Contact 15604 Oxide and other dielectrics 15605 Processing 15606 Devices 15607 Characterization 15701 Theory 15702 Growth mechanism 15703 Surface structures 15.8 Crystal evaluation, impurities and crystal defects 15801 Point defect 15802 Impurity effect 15803 Point defect 15803 Point defect 15804 Optical characterization 15805 Aryat avaluation, impurities and crystal defects 15806 Detical characterization 15807 Aryat devaluation impurities and crystal defects 15808 Impurity effect 15809 Optical characterization 15800 Aryat characterization 15801 Aryat characterization 15806 Electrical characterization 15806 Electrical characterization 15806 Electrical characterization 15806 Electrical characterization 15807 Aryat characterization 15808 Aryat characterization 15809 Aryat characterization 15800 Area characterization 15800 Area characterization 15801 Crystalline Materials 15010 Characterization 15801 Oxide materials 15010 Oxide materials 15010 Oxide materials 15010 Oxide materials 15010 Surface, interface, multilayers, stacked structures		
15508 Crystal growth 15509 Optical device 15601 Crystal growth 15602 Epitaxial growth 15603 Contact 15604 Oxide and other dielectrics 15605 Processing 15606 Devices 15607 Characterization 1577 Fundamentals of epitaxy 15701 Theory 15702 Growth mechanism 15703 Surface structures 15801 Point defect 15802 Impurity effect 15803 Hydrogenation 15804 Optical characterization 15805 Processing 15705 Conditional defects 15806 Devices 15706 Theory 15707 Theory 15708 Surface structures 15709 Growth mechanism 15709 Surface structures 15801 Electrical characterization 15802 Impurity effect 15803 Hydrogenation 15806 Electrical characterization 15806 Electrical characterization 15807 Chalcogenide materials 16101 Chalcogenide materials 16102 Oxide materials 16103 Fiber devices 16103 Organic-inorganic hybrid materials 16105 Organic-inorganic hybrid materials 16107 Surface, interface, multilayers, stacked structures 16108 Crystalline/amorphous mixed-phase materials		
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16108 Crystalline/amorphous mixed-phase materials		

Categor	у
Section	
No.	keyword (English)
	ocessing technologies and devices
	Chemical vapor deposition
	Sputtering, vapor-phase deposition
	In-situ diagnostics, growth mechanism
	Printing, coating, non-vacuum process
	Annealing, liquid/solid phase growth
	Thin-film devices (non-PV)
	Novel devices (non-PV)  lk, thin-film and other silicon-based solar cells
	Bulk crystalline silicon : growth and characterization
	Bulk crystalline silicon solar cells
	Thin-film silicon : fabrication and characterization
	Thin-film silicon solar cells
16305	Crystalline/amorphous heterojunction solar cells
16306	Light trapping, TCO
16307	Surface passivation
	Modules, testing, standardization
	Novel photovoltaic devices
	ocarbon Technology
	owth technology
	Nanotube
	Graphene
	Fullerene Other nanocarbon materials
	Other layered or two-dimensional materials
	CVD, plasma CVD
	Sublimation
	In-situ observation, new growth method
	Others
17.2 Str	uctural control and process
17201	Alignment
17202	Formation of special structure, composite structure
	Separation, dispersion, modification
	Surface, interface
	Stacking, stacking structure
	Others ploration of new functions and evaluation of basic properties
	Transport properties
	Optical properties
	Mechanical properties, thermal properties, and others
	vice application
	FET, and integrated circuit
	Quantum devices
17403	Optical devices
	Sensing devices
	Field emission
	NEMS and others
	P-OSA Joint Symposia
	sh sessions.
	Surface-enhanced spectroscopy
	Plasmonic nanoimaging
	Plasmonic antennas: design and fabrication
	Plasmonic circuits and waveguides
	Metamaterials
	o- and Medical Photonics
	Biomedical spectroscopy, microscopy, and imaging
	Clinical technologies and systems
	Cell manipulation
	Light tissue interaction
	Biosensors
	ser Manufacturing
	Laser additive manufacturing
	Laser deposition
	Laser joining
2000.	Laser for industrial use
10202	Education industrial duc

Categor	Category		
Section			
No.	keyword (English)		
18.4 Optical Micro-sensing, Manipulation, and Fabrications			
18401	Optical tweezers		
18402	Optical fiber sensing		
	Biomedical sensing		
18404	Sensing of microparticles		
18405	Manipulation of micro-particles		
18406	Sub-wavelength structures		
18407	Micro-fabrication with optical vortices		
18408	Micro-fabrications with nano-particles		
18409	Surface relief grating		
18410	Micro fabrications with fs and ps laser pulses		
18411	Interferometric micro fabrications		
18412	Optical materials with nano particles		
	to-electronics		
	Semiconductor laser and light emitter, photodetector		
	Si photonics, photonic crystal, optical modulator, optical switch, waveguide devices, and MEMS		
	Dielectric/ferroelectric materials and devices		
	III-V material and devices, IV material and devices		
	ormation Photonics		
	Digital / computer generated holography		
	Three-dimensional imaging and display		
	Computational imaging and display		
	Multispectral imaging		
	Polarimetric imaging		
	ser Photonics — XFEL and ultrafast optics —		
	Ultrafast laser & phenomena		
	High-intensity laser physics		
10,03	Attosecond science		
	New sources and applications of coherent ultrafast X-rays		
18.8 Carbon Photonics			
	Carbon nanotube		
	Graphene		
18803	Atomically-thin layered materials		
18804	Plasmonics		
18805	Optical devices		

21.1 Joint Session K "Wide bandgap oxide semiconductor materials and devices"		
21101	Crystal growth	
21102	Materials properties and characterization	
21103	Bandgap engineering	
21104	Heterostructures and multilayers	
21105	Doping	
21106	Transparent conducting film	
21107	Thin-film devices	
21108	Excitonic devices	
21109	Ultraviolet optical devices	

Symposium		
31.1	Interfacial nano electrochemistry: Research frontiers of semiconductor wet processes	
32.1	Phase problem in the analysis of buried interfaces by X-ray reflectivity and surface X-ray scattering - Towards new research	
	with coherent light sources	
33.1	Low-Temperature Growth of Group-IV Semiconductors on Insulator - Emerging New Crystallization Techniques -	
34.1	Current situation and issues of thin-film silicon solar cell technologies	
35.1	Japan-Korea Joint Symposium on Semiconductor Physics and Technology - Nano-carbon materials including graphene -	
36.1	Activity of the scientific enlightenment including upbringing of the student	
37.1	Micro and nano behavior of bio material surfaces and its application	
38.1	Oxide electronics at solid-liquid interfaces: Chemistry and device applications	
39.1	Surface reaction control by atomic and molecular beams, its development and application	
40.1	Computer Simulations for Plasma Processing (state-of-the-art plasma modelling)	
41.1	Frontier of Spintronic Materials and Devices	
42.1	Present and Future of Functional atomic thin film research	
43.1	応用物理に期待される資源リサイクルとエネルギー問題 (English title TBA)	
44.1	Behavior of nuclear fuel and fission products during severe accident and activities on decontamination	
45.1	量子計測技術における新展開 (English title TBA)	
46.1	New Frontiers and Future Perspectives in Surface Reaction Observation Using Synchrotron Radiation	
47.1	Innovation in R&D of the Flexible Electronics -Toward the Inorganic Flexible Devices-	
48.1	Materials Science of Singularity in Nitride semiconductors - Characterization and Crystallography-	